

<b>Notice of References Cited</b>	Application/Control No. 10/786,807		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Bac H. Au		Art Unit 2822	Page 1 of 1

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*	B	US-2003/0146518	08-2003	Hikita et al.	257/777
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#### NON-PATENT DOCUMENTS

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